BGA612

Silicon Germanium Broadband MMIC Amplifier

Small Signal Discretes



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BGA612, Silicon Germanium Broadband MMIC Amplifier

Revision History: 2008-04-24, Rev. 2.1

Previous Version: 2003-11-04

Page	Subjects (major changes since last revision)			
All	New Chip Version with integrated ESD protection			
5	Electrical Characteristics slightly changed			
7-8	Figures updated			
All	Document layout change			

Trademarks

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Data Sheet 3 Rev. 2.1, 2008-04-24



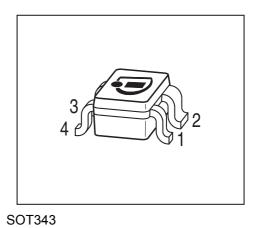
Silicon Germanium Broadband MMIC Amplifier

1 Silicon Germanium Broadband MMIC Amplifier

Feature

- Cascadable 50 Ω-gain block
- 3 dB-bandwidth: DC to 2.8 GHz with 17.5 dB typical gain at 1.0 GHz
- Compression point P_{-1dB} = 7 dBm at 2.0 GHz
- Noise figure $F_{50\Omega}$ = 2.1 dB at 2 GHz
- · Absolute stable
- 70 GHz f_T Silicon Germanium technology
- 1 kV HBM ESD protection (Pin-to-Pin)
- Pb-free (RoHS compliant) package¹⁾





Applications

- Driver amplifier for GSM/PCS/CDMA/UMTS
- · Broadband amplifier for SAT-TV & LNBs
- · Broadband amplifier for CATV
- 1) Pb-containing package may be available upon special request

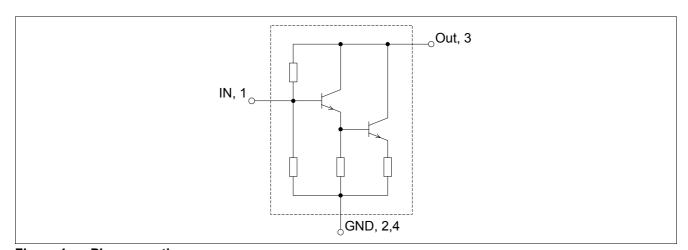


Figure 1 Pin connection

Description

BGA612 is a broadband matched, general purpose MMIC amplifier in a Darlington configuration. It is optimized for a typical supply current of 20 mA

The BGA612 is based on Infineon Technologies' B7HF Silicon Germanium technology.

Туре	Package	Marking
BGA612	SOT343	BNs

Note: **ESD:** Electrostatic discharge sensitive device, observe handling precaution



Electrical Characteristics

Maximum Ratings

Table 1 **Maximum ratings**

Parameter	Symbol	Limit Value	Unit	
Device voltage	V_{D}	2.8	V	
Device current	I_{D}	80	mA	
Current into pin In	I_{in}	0.7	mA	
Input power ¹⁾	P_{in}	10	dBm	
Total power dissipation, $T_{\rm S}$ < 105 °C ²⁾	P_{tot}	225	mW	
Junction temperature	T_{J}	150	°C	
Ambient temperature range	T_{A}	-65 150	°C	
Storage temperature range	T_{STG}	-65 150	°C	
ESD capability all pins (HBM: JESD22-A114)	V _{ESD}	1000	V	

Note: All Voltages refer to GND-Node

Thermal resistance

Table 2 Thermal resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R_{thJS}	200	K/W

¹⁾ For calculation of R_{thJA} please refer to Application Note Thermal Resistance

Electrical Characteristics 2

Electrical characteristics at $T_{\rm A}$ = 25 °C (measured in test circuit specified in Figure 2)

 $V_{\rm CC}$ = 5 V, $R_{\rm Bias}$ = 135 Ω , Frequency = 2 GHz, unless otherwise specified

Table 3 **Electrical Characteristics**

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Condition
Insertion power gain	$ S_{21} ^2$		18.0		dB	f = 0.1 GHz
			17.5		dB	f = 1.0 GHz
			16.3		dB	f = 2.0 GHz
Noise figure ($Z_{\rm S}$ = 50 Ω)	$F_{50\Omega}$		1.8		dB	f = 0.1 GHz
			2.0		dB	f = 1.0 GHz
			2.1		dB	f = 2.0 GHz
Output power at 1 dB gain compression	$P_{ ext{-1dB}}$		7		dBm	
Output third order intercept point	OIP_3		17		dBm	
Input return loss	$RL_{\sf in}$		17		dB	
Output return loss	RL_{out}		17		dB	
Total device current	I_{D}		20		mA	

¹⁾Valid for $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω , $V_{\rm CC}$ = 5 V, $R_{\rm Bias}$ = 135 Ω 2) $T_{\rm S}$ is measured on the ground lead at the soldering point



Electrical Characteristics

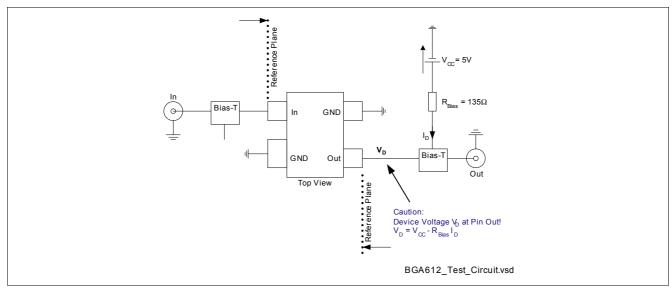
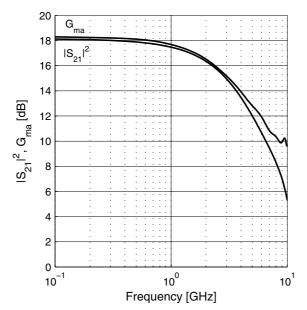


Figure 2 Test Circuit for Electrical Characteristics and S-Parameter

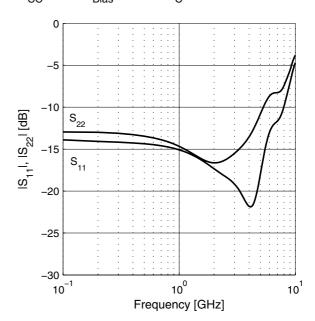
Measured Parameters

3 Measured Parameters

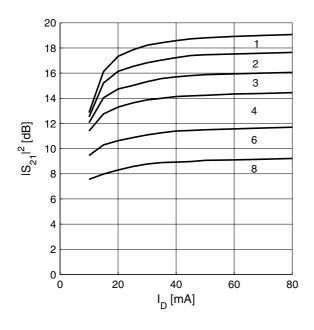
Power Gain
$$|S_{21}|^2$$
, $G_{ma} = f(f)$
 $V_{CC} = 5V$, $R_{Bias} = 135Ω$, $I_{C} = 20mA$



$$\begin{aligned} & \textbf{Matching} \ |\textbf{S}_{11}|, \ |\textbf{S}_{22}| = \textbf{f(f)} \\ & \textbf{V}_{CC} = \textbf{5V}, \ \textbf{R}_{Bias} = \textbf{135}\Omega, \ \textbf{I}_{C} = \textbf{20mA} \end{aligned}$$

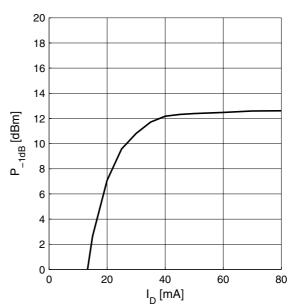


Power Gain $|S_{21}| = f(I_D)$ f = parameter in GHz



Output Compression Point

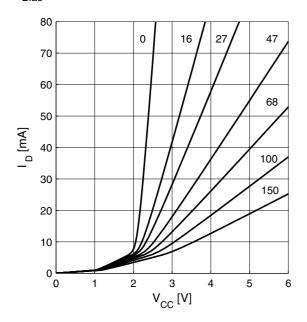
$$\boldsymbol{P}_{-1dB} = \boldsymbol{f}(\boldsymbol{I}_{D}), \, \boldsymbol{f} = 2GHz$$



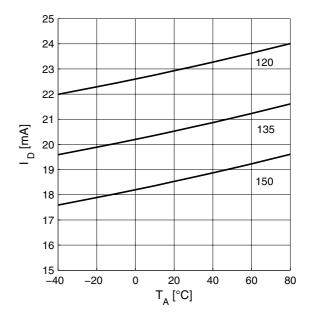


Measured Parameters

$$\begin{array}{l} \textbf{Device Current I}_{D} = \text{f(V}_{CC}) \\ \textbf{R}_{Bias} = \text{parameter in } \Omega \\ \end{array}$$

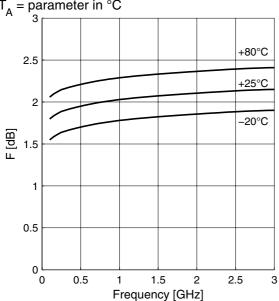


Device Current I $_{\rm D}$ = f(T $_{\rm A}$) V $_{\rm CC}$ = 5V, R $_{\rm Bias}$ = parameter in Ω



Noise figure F = f(f)

$$V_{CC} = 5V$$
, $R_{Bias} = 135\Omega$, $Z_{S} = 50\Omega$
 $T_{A} = parameter in °C$





Package Information

4 Package Information

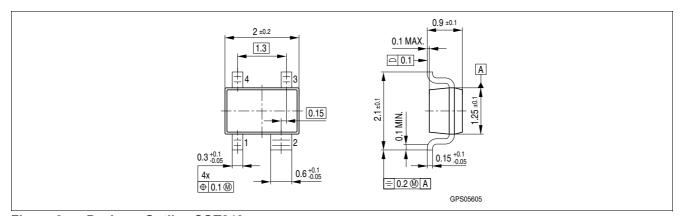


Figure 3 Package Outline SOT343

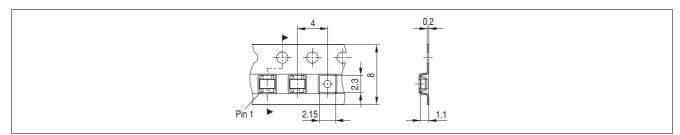


Figure 4 Tape for SOT343